

NTMKE4894N

Power MOSFET

25 V, 160 A, Single N-Channel, ICEPAK™

Features

- Low Package Inductance
- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- This is a Pb-Free Device

Applications

- CPU Power Delivery
- DC-DC Converters
- Optimized for Control FET

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter		Symbol	Value	Unit
Drain-to-Source Voltage		V_{DS}	25	V
Gate-to-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current $R_{\theta JA}$ (Note 1)	$T_A = 25^\circ\text{C}$	I_D	33	A
	$T_A = 70^\circ\text{C}$		26.4	
Power Dissipation $R_{\theta JA}$ (Note 1)	$T_A = 25^\circ\text{C}$	P_D	2.8	W
Continuous Drain Current $R_{\theta J-PCB}$ (Note 2)	$T_A = 25^\circ\text{C}$	I_D	160	A
	$T_A = 70^\circ\text{C}$		88.6	
Power Dissipation $R_{\theta J-PCB}$ (Note 2)	$T_A = 25^\circ\text{C}$	P_D	65	W
Continuous Drain Current $R_{\theta JC}$ (Note 1)	$T_C = 25^\circ\text{C}$	I_D	170	A
	$T_C = 70^\circ\text{C}$		136	
Power Dissipation $R_{\theta JC}$ (Note 1)	$T_C = 25^\circ\text{C}$	P_D	73.5	W
Pulsed Drain Current	$T_A = 25^\circ\text{C}$, $t_p = 10 \mu\text{s}$	I_{DM}	250	A
Current Limited by Package	$T_A = 25^\circ\text{C}$	I_{Dmax}	50	A
Operating Junction and Storage Temperature		T_J , T_{stg}	-40 to 150	$^\circ\text{C}$
Source Current (Body Diode) (Note 1)		I_S	92	A
Drain to Source DV/DT		dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25^\circ\text{C}$, $V_{DD} = 25 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_L = 62 \text{ A}_{pk}$, $L = 0.3 \text{ mH}$, $R_G = 25 \Omega$)		E_{AS}	577	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T_L	270	$^\circ\text{C}$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

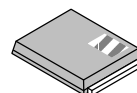
1. Surfaced mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
2. Measured with a T_J of approximately 90°C using 1 oz Cu board.
3. Surfaced mounted on FR4 board using 1 sq-in pad, 2 oz Cu.



ON Semiconductor®

<http://onsemi.com>

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ MAX}$	$I_D \text{ MAX}$
25 V	1.7 m Ω @ 10 V	160 A
	2.4 m Ω @ 4.5 V	



ICEPAK
E PAD
CASE 145AB

MARKING DIAGRAM



E4894 = Specific Device Code

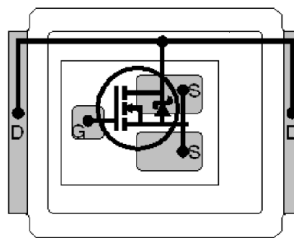
A = Assembly Location

Y = Year

WW = Work Week

▪ = Pb-Free Package

(Note: Microdot may be in either location)



ORDERING INFORMATION

Device	Package	Shipping†
NTMKE4894NT1G	ICEPAK (Pb-Free)	1500/Tape & Reel
NTMKE4894NT3G	ICEPAK (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	1.7	°C/W
Junction-to-Ambient – Steady State (Note 1)	$R_{\theta JA}$	45	
Junction-to-Ambient – Steady State (Notes 2 and 3)	$R_{\theta JA}$	25	
Junction-to-PCB (Note 2)	$R_{\theta J-PCB}$	1.0	

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$			20		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0\text{ V}, V_{DS} = 20\text{ V}$	$T_J = 25^\circ\text{C}$		1.0	μA
			$T_J = 125^\circ\text{C}$		100	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			± 100	nA

ON CHARACTERISTICS (Note 4)

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\text{ }\mu\text{A}$	1.4		2.4	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$			5.9		mV/°C
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 30\text{ A}$		1.3	1.7	$\text{m}\Omega$
		$V_{GS} = 4.5\text{ V}, I_D = 30\text{ A}$		1.9	2.4	
Forward Transconductance	g_{FS}	$V_{DS} = 13\text{ V}, I_D = 27\text{ A}$	100	139		S

CHARGES, CAPACITANCES AND GATE RESISTANCE

Input Capacitance	C_{iss}	$V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}, V_{DS} = 13\text{ V}$		7130		pF
Output Capacitance	C_{oss}			1605		
Reverse Transfer Capacitance	C_{rss}			830		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 13\text{ V}, I_D = 27\text{ A}$		51.3		nC
Threshold Gate Charge	$Q_{G(TH)}$			6.0		
Gate-to-Source Charge	Q_{GS}			19.2		
Gate-to-Drain Charge	Q_{GD}			18.6		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 10\text{ V}, V_{DS} = 13\text{ V}, I_D = 27\text{ A}$		100.8		nC

SWITCHING CHARACTERISTICS (Note 5)

Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 13\text{ V}, I_D = 27\text{ A}, R_G = 1.8\text{ }\Omega$		25		ns
Rise Time	t_r			30		
Turn-Off Delay Time	$t_{d(off)}$			40		
Fall Time	t_f			12		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = 27\text{ A}$	$T_J = 25^\circ\text{C}$		0.8	1.0	V
			$T_J = 125^\circ\text{C}$		0.65		
Reverse Recovery Time	t_{RR}	$V_{GS} = 0\text{ V}, dI_S/dt = 200\text{ A}/\mu\text{s}, I_S = 27\text{ A}$		50		ns	
Charge Time	t_a			21			
Discharge Time	t_b			29			
Reverse Recovery Charge	Q_{RR}			74		nC	

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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PACKAGE PARASITIC VALUES

Source Inductance	L_S	$T_A = 25^\circ\text{C}$		TBD		nH
Drain Inductance	L_D			TBD		nH
Gate Inductance	L_G			TBD		nH
Gate Resistance	R_G			0.5	1.5	Ω

4. Pulse Test: pulse width = 300 μs , duty cycle $\leq 2\%$.
5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

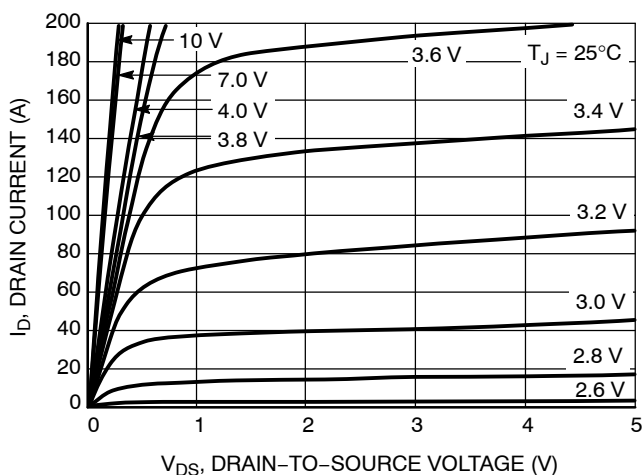


Figure 1. On-Region Characteristics

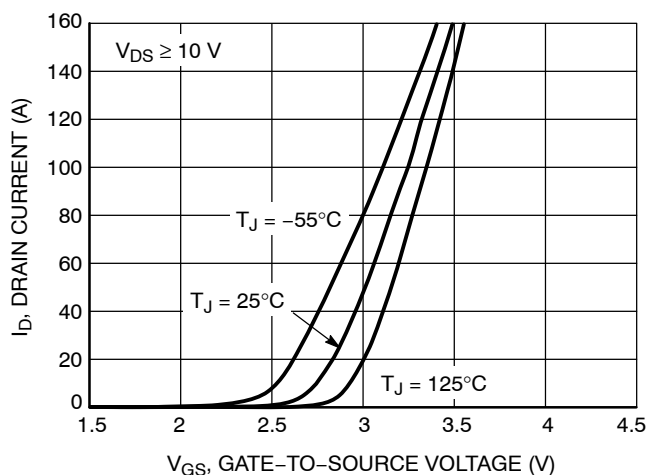


Figure 2. Transfer Characteristics

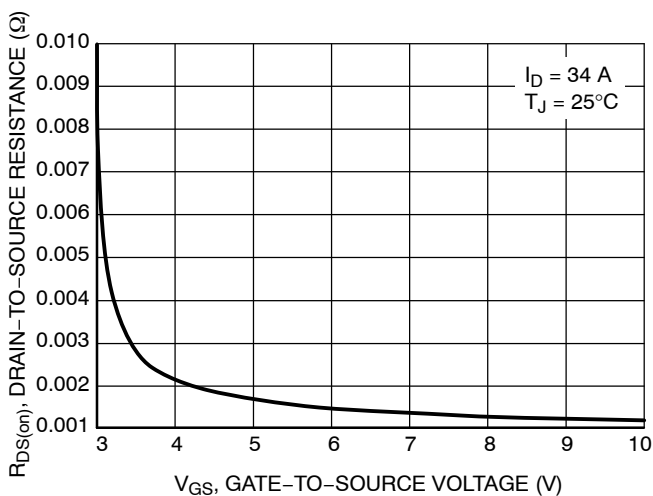


Figure 3. On-Resistance vs. Gate-to-Source Voltage

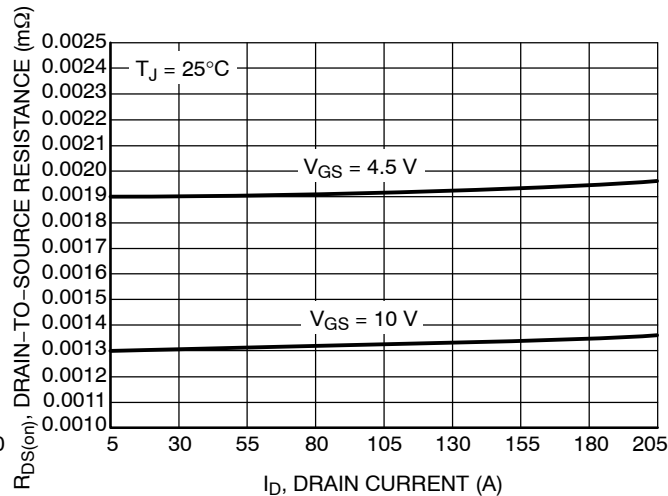


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

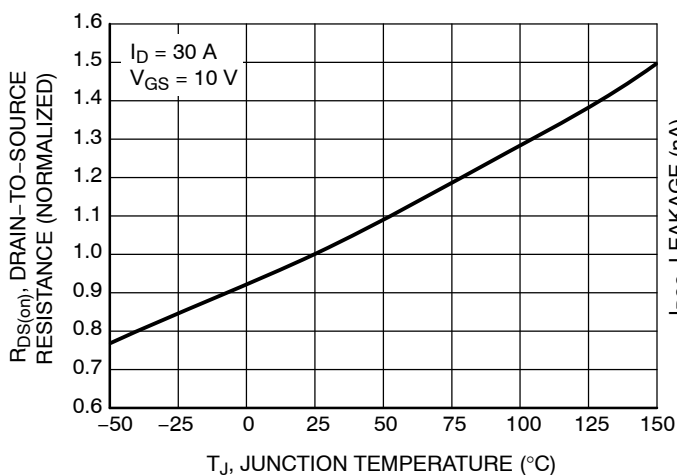


Figure 5. On-Resistance Variation with Temperature

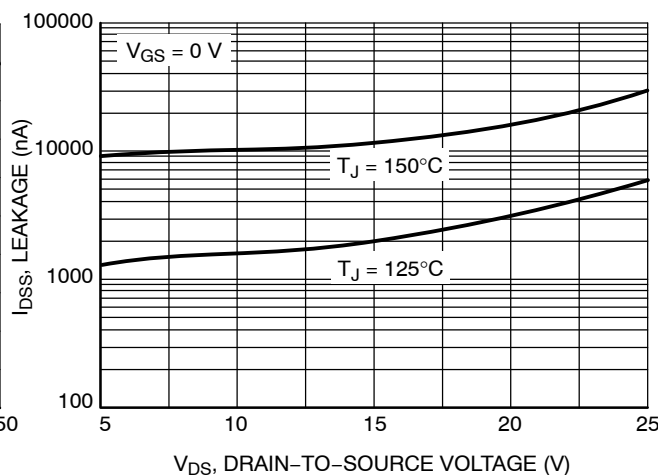


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

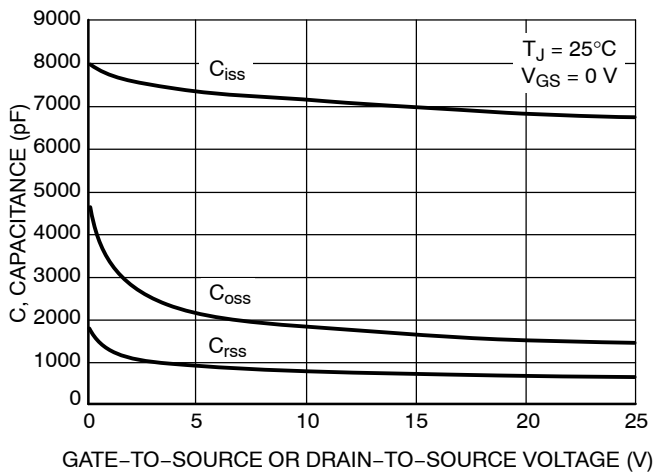


Figure 7. Capacitance Variation

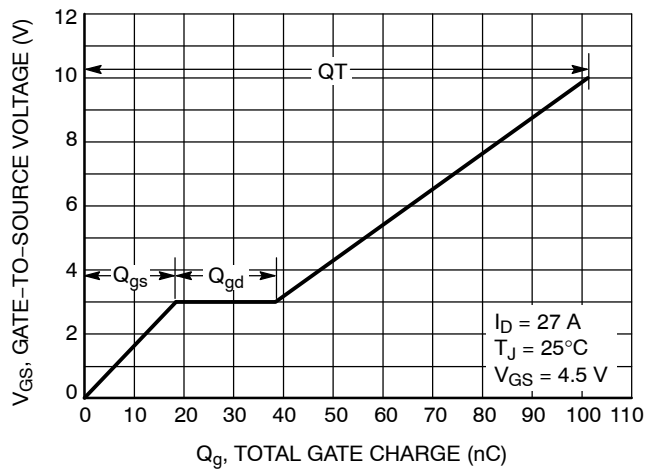


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

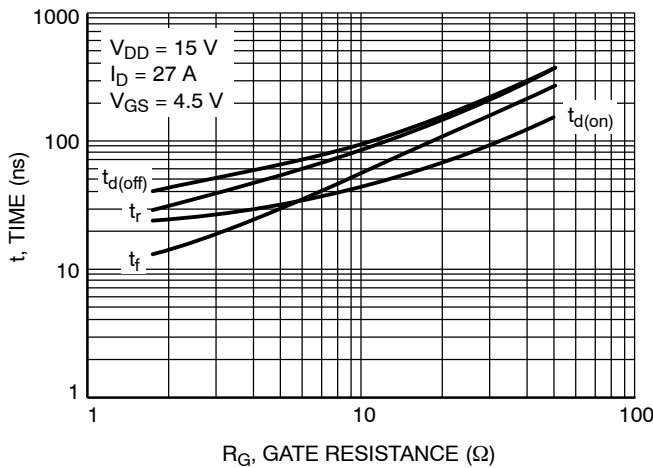


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

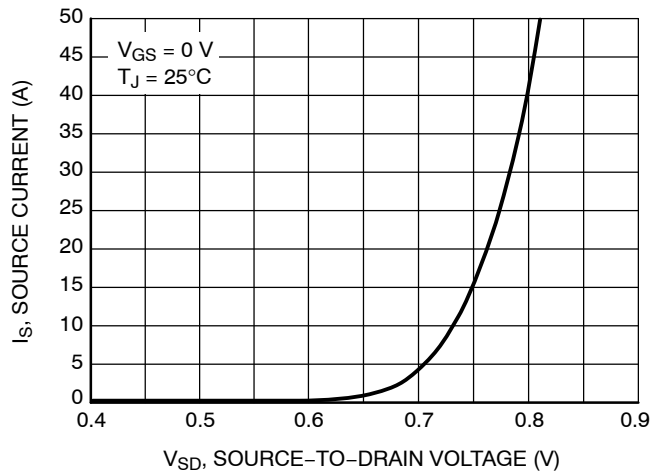


Figure 10. Diode Forward Voltage vs. Current

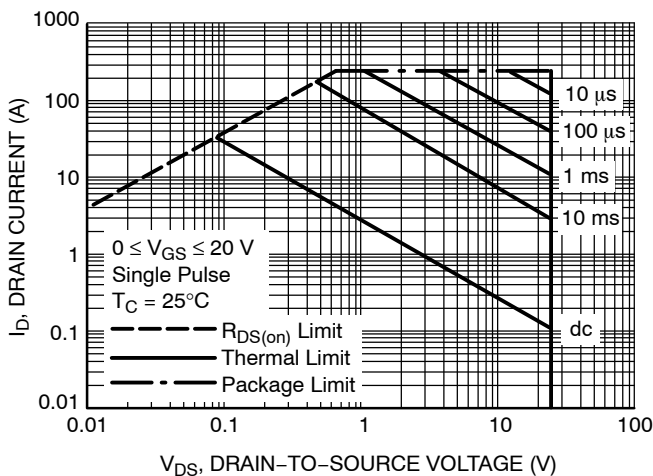


Figure 11. Maximum Rated Forward Biased Safe Operating Area

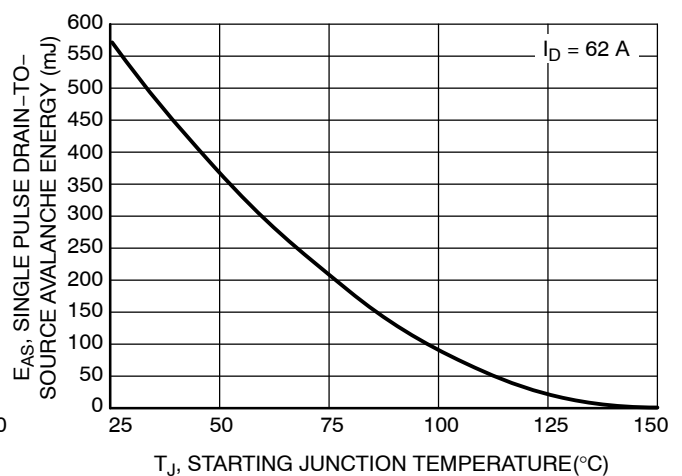


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

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TYPICAL CHARACTERISTICS

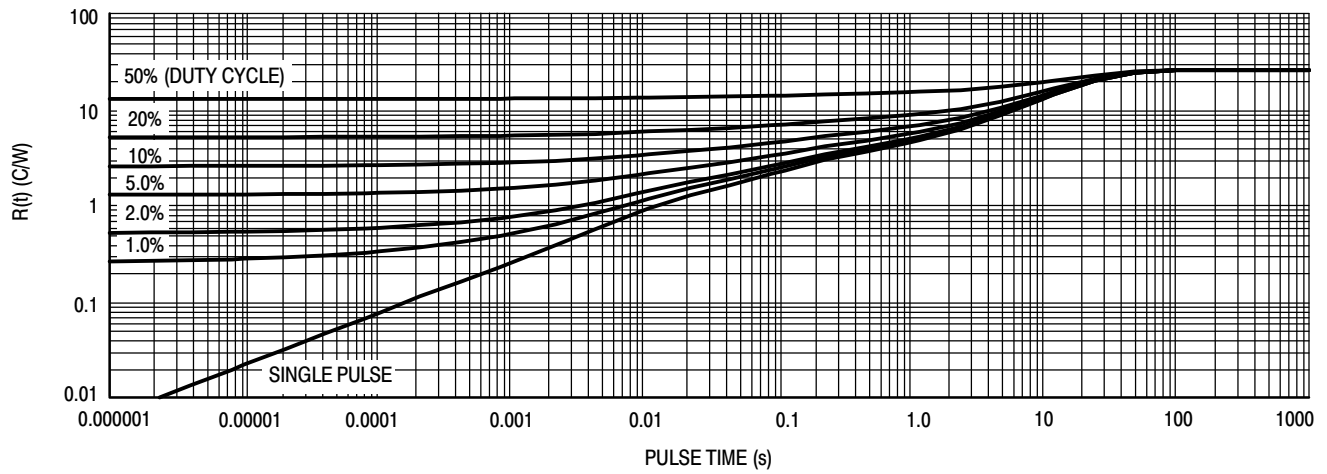
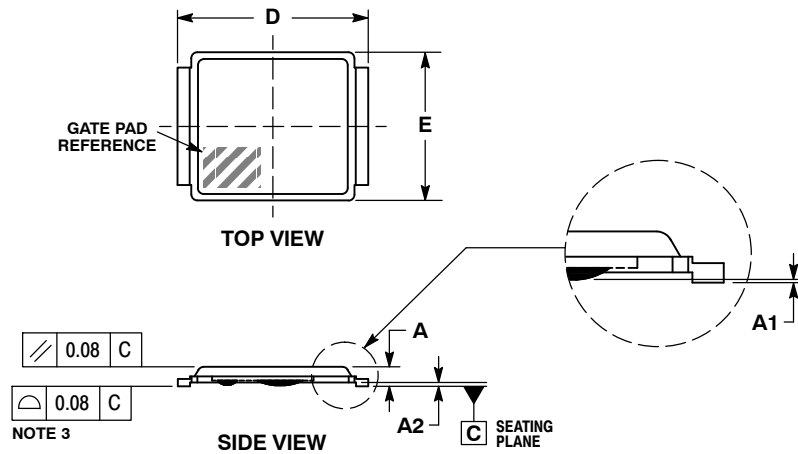


Figure 13. Thermal Impedance

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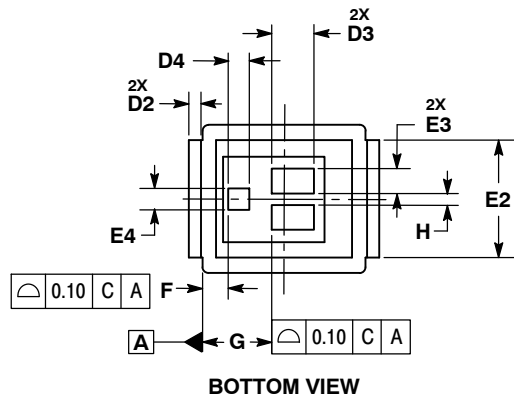
PACKAGE DIMENSIONS

ICEPAK 6.3x4.9 – E PAD
CASE 145AB-01
ISSUE O

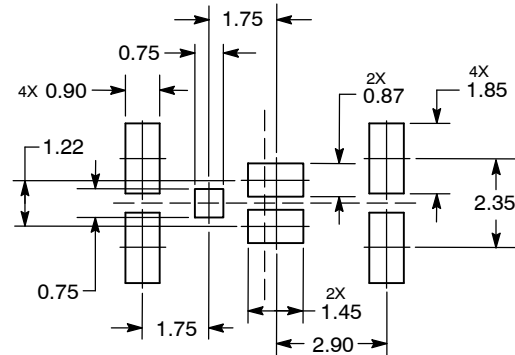


- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. COPLANARITY APPLIES TO THE FLANGES OF LEADFRAME ONLY.

DIM	MILLIMETERS	
	MIN	MAX
A	0.61	0.68
A1	0.02	0.08
A2	0.08	0.17
D	6.25	6.35
D2	0.35	0.45
D3	1.38	1.42
D4	0.68	0.72
E	4.80	5.05
E2	3.85	3.95
E3	0.80	0.84
E4	0.68	0.72
F	0.94 BSC	
G	2.54 BSC	
H	0.38	0.42




SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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